

Notice of References CitedApplication/Control
09/664,858Applicant(s)/Patent Under
Reexamination
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2154

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,411,735	06-2002	Williams et al.	382/224
	B	US-6,445,783	09-2002	Creswell et al.	379/207.13
	C	US-6,434,171	08-2002	Ishida, Tadahiro	370/537
	D	US-6,256,071	07-2001	Hiroi, Kazushige	348/553
	E	US-6,373,527	04-2002	Lee, Tae-Sung	348/564
	F	US-6,549,658	04-2003	Schweid et al.	382/173
	G	US-5,367,522	11-1994	Otani, Masatoshi	370/468
	H	US-6,185,228	02-2001	Takashimizu et al.	370/535
	I	US-5,675,789	10-1997	Ishii et al.	707/204
	J	US-5,848,137	12-1998	Hsiao, Ray-Ling	379/110.01
	K	US-6,621,588	09-2003	Shimada, Muneki	358/1.15
	L	US-6,453,302	09-2002	Johnson et al.	705/27
	M	US-6,493,461	12-2002	Mennie et al.	382/135

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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